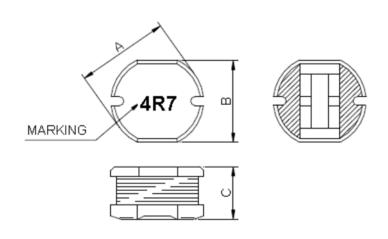


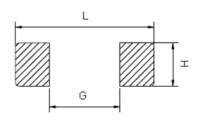
FEATRLRES

- Excellent solderability and high heat resistance.
- Excellent terminal strength construction.
- Packed in embossed carrier tape and can be used by automatic mounting machine.
- 100% Lead(Pb) & Halogen-Free and RoHS compliant.

CONFIGRLRATIONS & DIMENSIONS (unit in mm)



Recommended Land pattern



Size	Α	В	С	L	G	Н
HSDR73	7.80±0.3	7.00±0.3	3.50±0.3	8.0	2.0	7.5

ELECTRICAL CHARACTERISTICS

Part Number	Inductance (uH)	Tolerance (%)	Test Frequency	DCR	IDC
			(Hz)	(Ω) max.	(A) max.
HSDR73-100M	10	± 20%	1V/2.52M	0.0803	1.44
HSDR73-120M	12	± 20%	1V/2.52M	0.0897	1.39
HSDR73-150M	15	± 20%	1V/2.52M	0.1040	1.24
HSDR73-180M	18	± 20%	1V/2.52M	0.1110	1.12
HSDR73-220M	22	± 20%	1V/2.52M	0.1290	1.07
HSDR73-270M	27	± 20%	1V/2.52M	0.1530	0.97
HSDR73-330M	33	± 20%	1V/2.52M	0.1700	0.85
HSDR73-390M	39	± 20%	1V/2.52M	0.2170	0.74
HSDR73-470M	47	± 20%	1V/2.52M	0.2520	0.68
HSDR73-560K	56	± 10%	1V/2.52M	0.2820	0.64
HSDR73-680K	68	± 10%	1V/2.52M	0.3320	0.59
HSDR73-820K	82	± 10%	1V/2.52M	0.4060	0.54



HSDR73-101K	100	± 10%	1V/1K	0.4810	0.51
HSDR73-121K	120	± 10%	1V/1K	0.5360	0.49
HSDR73-151K	150	± 10%	1V/1K	0.7550	0.40
HSDR73-181K	180	± 10%	1V/1K	1.0220	0.36
HSDR73-221K	220	± 10%	1V/1K	1.2000	0.31
HSDR73-271K	270	± 10%	1V/1K	1.3060	0.29
HSDR73-331K	330	± 10%	1V/1K	1.4950	0.28

Note:

Based on inductance change $(\triangle L/L0 : \le -35\%)$ @ ambient temp. 25°C Based on temperature rise $(\triangle T : 40$ °C typ.)

Reliability and Test Condition

Item	Performance	Test Condition
Operating temperature	-40~+125℃ (Including self - temperature rise)	
Storage temperature	110~+40°C,50~60%RH (Product with taping) 240~+125°C (on board)	
Electrical Performance Test		
Inductance	Refer to standard electrical characteristics list.	HP4284A,CH11025,CH3302,CH1320,CH1320S LCR Meter.
DCR	Refer to standard electrical characteristics list.	CH16502,Agilent33420A Micro-Ohm Meter.
Saturation Current (Isat)	Approximately△L30%	Saturation DC Current (Isat) will cause L0 to drop $\triangle L(\%)$
Heat Rated Current (Irms)	Approximately △T40°C	Heat Rated Current (Irms) will cause the coil temperature rise $\triangle T(^{\circ}C)$. 1.Applied the allowed DC current 2.Temperature measured by digital surface thermometer
Reliability Test		
Life Test		Preconditioning: Run through IR reflow for 2 times.(IPC/JEDEC J-STD-020Dclassification Reflow Profiles) Temperature: 125±2°C (Inductor) Applied current: rated current Duration: 1000±12hrs Measured at room temperature after placing for 24±2 hrs
Load Humidity		Preconditioning: Run through IR reflow for 2 times.(IPC/JEDEC J-STD-020DClassification Reflow Profiles Humidity: 85±2 × R.H, Temperature: 85℃±2℃ Duration: 1000hrs Min. with 100% rated current Measured at room temperature after placing for 24±2 hrs
Moisture Resistance	Appearance: No damage. Inductance: within±10% of initial value Q: Shall not exceed the specification value. RDC: within ±15% of initial value and shall not exceed the specification value	Preconditioning: Run through IR reflow for 2 times.(IPC/JEDEC J-STD-020DClassification Reflow Profiles 1. Baked at50°C for 25hrs, measured at room temperature after placing for 4 hrs. 2. Raise temperature to 65±2°C 90-100%RH in 2.5hrs, and keep 3 hours, cool down to 25°C in 2.5hrs. 3. Raise temperature to 65±2°C 90-100%RH in 2.5hrs, and keep 3 hours, cool down to 25°C in 2.5hrs, keep at 25°C 80-100%RH for 15min and vibrate at the frequency of 10 to 55 Hz to 10 Hz, measure at room temperature after placing for 1~2 hrs.
Thermal shock		Preconditioning: Run through IR reflow for 2 times.(IPC/JEDEC J-STD-020DClassification Reflow Profiles Condition for 1 cycle Step1: $-40\pm2^{\circ}$ C 30 \pm 5min Step2: $25\pm2^{\circ}$ C \leq 0.5min Step3: $125\pm2^{\circ}$ C 30 \pm 5min Number of cycles: 500 Measured at room temperature after placing for 24 \pm 2 hrs



		Ossillation Fraguency: 10 2K 10Hz for 20 minutes			
Vibration		Oscillation Frequency: 10 ~ 2K ~ 10Hz for 20 minutes Equipment: Vibration checker			
		Total Amplitude:1.52mm±10%			
		Testing Time: 12 hours(20 minutes, 12 cycles each of 3			
		orientations),			
Bending		Shall be mounted on a FR4 substrate of the following dimensions: >=805 inch(2012mm):40x100x1.2mm <0805 inch(2012mm):40x100x0.8mm Bending depth: >=0805 inch(2012mm):1.2mm <0805 inch(2012mm):0.8mm duration of 10 sec.			
Shock	Appearance: No damage. Impedance: within±15% of initial value Inductance: within±10% of initial value Q: Shall not exceed the specification value.	Type Value duration (D) Wave change (Vi)ft/sec			
Citati	RDC : within ±15% of initial value and shall not	SMD 50 11 Half-sine 11.3			
	exceed the specification value	Lead 50 11 Half-sine 11.3			
Solder ability	More than 95% of the terminal electrode should be covered with solder.	Preheat: 150°C,60sec Solder: Sn96.5% Ag3% Cu0.5% Temperature: 245±5°C ° Flux for lead free: Rosin. 9.5% ° Dip time: 4±1sec ° Depth: completely cover the termination Depth: completely cover the termination			
Resistance to Soldering Heat		Temperature(°C) Time(s) Temperature ramp/immersion and emersion rate Number of heat cycles			
		260 ±5 (solder temp) 10 ±1 25mm/s ±6 mm/s 1			
Terminal Strength	Appearance: No damage. Impedance: within±15% of initial value Inductance: within±10% of initial value Q: Shall not exceed the specification value. RDC: within ±15% of initial value and shall not exceed the specification value e	Preconditioning: Run through IR reflow for 2 times.(IPC/JEDEC J-STD 020DClassification Reflow Profiles With the component mounted on a PCB with the device to be tested apply a force(>0805:1kg), <=0805:0.5kg)to the side of a device being tested. This force shall be applied for 60 +1 seconds. Also the force sha be applied gradually as not to apply a shock to the component being tested.			

Note : When there are questions concerning measurement result : measurement shall be made after 48 ± 2 hours of recovery under the standard condition.